# **Dan Clare**

# Lecture 5 Contrast Transfer and CTF Correction

Types of Contrast/Transfer The Weak Phase Object Approximation **Contrast Transfer Function Determining Defocus CTF** Correction Methods **Tilted Images** Phase Plates



Image processing for cryo microscopy

2 - 12 September 2019



**Practical Course** Birkbeck College London

## **Contrast Transfer**



#### Types of Contrast in TEM



Review of :

EM image = projected electron scattering density of object modified by the CTF

If the object is thin and weakly scattering (ie made of light atoms), a simplified form of the CTF function can be derived.

The phase shift  $\Phi(\mathbf{r})$  from a **weak phase object** is small, and the wave expression  $\psi \exp[i\Phi(\mathbf{r})]$  can be approximated by the series

 $\psi [1 + i\Phi(\mathbf{r}) - \frac{1}{2} \Phi(\mathbf{r})^2 + \frac{1}{3} \Phi(\mathbf{r})^3 - ...]$ 

Because the phase shift is small, the 3rd order and higher terms can be ignored.

This approximation, combined with the phase shift introduced by **spherical aberration**, leads to the expression for the *phase contrast transfer function*, given on the next slide.

## Phase CTF = -2 sin [ $\pi(\Delta z \lambda q^2 - C_s \lambda^3 q^4/2)$ ]

 $C_s$  – spherical aberration coefficient  $\Delta Z$  – defocus q – spatial frequency  $\lambda$  – electron wavelength

• The only variable that we have to determine during CTF determination is the defocus (varied during the experiment)

#### Phase Contrast in TEM



No additional phase shift from the path length difference between the scattered and un-scattered electron wave (low scattering angles) = no contrast

Additional 90° phase shift from the path length difference between the scattered and un-scattered electron wave = negative contrast

Additional 270° phase shift from the path length difference between the scattered and un-scattered electron wave = positive contrast



#### Why Defocus an Image?



 $2 \ \mu m$ 



Tricorn protease, Walz, J et al (1997) Mol Cell 1, 59-65

#### Phase Contrast in TEM



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#### **Defocus Generates Contrast**



- As more defocus is used the relative phase shift between the scattered and un-scattered electrons waves at low spatial frequencies is increased making it easier to see your object.
- However this increases the number of zero and contrast reversal!

### Ideal CTF curves



#### FEG images of carbon film



images

Diffraction patterns/ FT plots

## Causes of CTF decay

• Loss of spatial coherence - source size



- Image drift (\*Motion correction\*)
- Thick ice
- Specimen charging (\*Grid type and support\*)
- Chromatic aberration variation in voltage
- Variation of lens current

### Decay caused by loss of spatial coherence



#### underdefocus = $0.5 - 4 \mu m$ Beam divergence = 1 mrad



s [1/A]

#### Effects of drift on CTF



Problem of the past with motion correction?

## The CTF is the FT of the Point Spread Function



## Effects of CTF on 2D projections

5 nm					\$
0.7 µm		â	ę	ø	٩
1.4 µm	(III)	ê	ß	ø	*
2.1		۵	ß	0	*
2.8		۵	ß	Ø	۲
3.5	488	0	ß	0	۲

### Effects of CTF on a 3D map



## Why don't I see Thon rings???

- Ice too thick
- No carbon in image
- Too little specimen vitreous ice alone does not give Thon rings!\* (and too thin ice excludes sample )
- Too close to focus on a non-FEG source



\*Not in all circumstances McMullan et al., 2015

#### Measuring defocus



Rotationally averaged total sum of image power spectra; band-pass filtered

Profile of the averaged spectrum

## CTF ripples are superimposed on a large background of incoherent scattering, noise and other features



#### Procedures for measuring defocus and CTF correction

**EMAN2** - evalimage graphical interface http://blake.bcm.edu/emanwiki/EMAN2/Programs/e2evalimage

Bsoft – Nice graphical interface and can be used for CTF correction

CTFFIND4 – graphical/automated Chops up areas into boxes Uses estimate of starting defocus Searches over a specified range of defocus Estimates astigmatism Gives split display output for verification of result http://grigoriefflab.janelia.org/ctffind4

**GCTF** – GPU accelerated CTF determination with local refinement. Zhang (2016) JSB 193, 1-12.

**IMOD** – Defocus determination on single tilts or groups of tilted images and strip based correction on individual tilt images.

**Nova CTF** – 3D CTF correction for subtomogram averaging. Separate correction of each subtomogram. Turonova et al (2017) JSB.

#### CTFFIND4 and GCTF output



#### Astigmatism





#### How to measure an astigmatic CTF



The ellipse must be fitted or measured in sectors to get the degree and angle of astigmatism so that the zeroes can be correctly determined for all directions.

#### CTF curves from different images- what range do we need



### Methods of CTF correction



1. Phase flipping - can be done on raw images

Multiplication in Fourier space by a simple box function = 1 and -1

#### Full CTF correction

2. <u>Full restoration of amplitudes</u>: Multiply each image FT by its own CTF, then add up all the equivalent views and divide the sum by the sum of all the CTF's squared, plus a constant related to the signal:noise ratio (Wiener factor) to avoid division by zero.



### Effect of Wiener filtering



- $2x10^{-4} \quad 2x10^{-3} \quad 2x10^{-2} \quad 2x10^{-1} \quad 2x10^{0} \quad 2x10^{1} \quad 2x10^{2} \quad 2x10^{3}$ 
  - The larger the value of w, the more small fluctuations are suppressed similar to low pass filtering

#### Steps in full amplitude restoration



This can only be done by combining images
of different defocus

#### Defocus and Thon ring variations in tilted samples



5 nm gold on carbon film, tilted to 65°4.9 μm underfocus6 μm underfocus7.1 μm underfocus

http://bio3d.colorado.edu/RML\_2017/2017\_IMOD\_PEET\_Workshop/Lectures/CTFcorrInIMOD.pdf

#### Tilt geometry and defocus



Fig. 1. Computation of a strip in an image of a tilted specimen.  $\Delta D$  represents the defocus range considered as a single defocus value, T denotes the defocus range in the strip, t is the thickness of the specimen and  $\theta$  is the tilt angle. The tilt axis runs perpendicular to the sheet and is marked by the black circle in the middle of the specimen slab.

Fig. 4. Extraction of a strip with a single effective defocus value from a tilted specimen. The square represents an image acquired from the tilted specimen. The tilt axis runs along the *Y*-axis. *x* denotes the index of the *x*-line around which the strip is extracted. d(x) represents the distance from the *x*-line to the tilt axis.

*from* Fernandez, Li & Crowther (2006) CTF determination and correction in electron cryotomography. Ultramicrosc. 106, 587-596. Strip CTF correction is implemented in IMOD

### Nova CTF and point spread functions



#### Phase plates



Thanks to Christos Savva for the slide

#### Volta Phase plates – effect on contrast and CTF

#### Phase contrast

#### Volta-phase plate



• Huge increase in low frequency contrast (low resolution features)

#### Volta Phase plates – effect on contrast and CTF continued



- Increasing phase shift improves contrast as the interference between the un-scattered and scattered electrons, particularly at low spatial frequencies, is increased.
- The CTF zero's shift towards the centre of the power spectra as the phase shift increases (increase in the relative speed of un-scattered electrons as the phase shift increase).
- Limited defocus values can be used as the variation in phase shift will change the zero positions for a set defocus.

#### Volta Phase plates – effect on contrast and CTF continued



2.5

3.0

#### Volta Phase plates



Volta phase plate

\*Thanks to Christos Savva for the protein and Yuriy Chaban for the GO grid prep

#### References

- Reimer, L (1989) Transmission electron microscopy. Springer-Verlag, Berlin
- Hawkes & Valdrè (1990) Biophysical electron microscopy. Academic Press, London.
- Toyoshima & Unwin (1988) Contrast transfer for frozen-hydrated specimens: determination from pairs of defocused images. Ultramicroscopy 25, 279-291.
- Wade, R. H. (1992) A brief look at imaging and contrast transfer. Ultramicrosc. 46:145-156.
- Toyoshima, C., K. Yonekura and H. Sasabe (1993) Contrast transfer for frozen-hydrated specimens II. Amplitude contrast at very low frequencies. Ultramicrosc. 48:165-176.
- Erickson, H. P. and A. Klug (1971) Measurement and compensation of defocusing and aberrations by fourier processing of electron micrographs. Phil. Trans. R. Soc. Lond. B. 261:105-118.
- Unwin, P. N. T. (1973) Phase contrast electron microscopy of biological materials. J. Microsc. 98:299-312.
- Rohou, A & Grigorieff, N (2015) CTFFIND4: Fast and accurate defocus estimation from electron micrographs. J Struct Biol 192, 216–221.
- Heymann JB (2001) Bsoft: Image and molecular processing in electron microscopy. J. Struct. Biol. 133(2/3): 156 169.
- Zhang, K (2016) Gctf: Real-time CTF determination and correction J Struct Biol 193, 1–12.
- McMullan, G. et al. (2015) Thon rings from amorphous ice and implications of beam-induced Brownian motion in single particle electron cryo-microscopy. Ultramicroscopy 158, 26-32.
- Turonova, Schur, Wan & Briggs (2017) Efficient 3D-CTF correction for cryo-electron tomography using NovaCTF improves subtomogram averaging resolution to 3.4 Å. J Struct Biol 199, 187-195.
- Danev, R. et al., (2014) Volta potential phase plate for in-focus phase contrast transmission electron microscopy. PNAS, 111, 15635-15640.
- Danev, R. et al., (2017) Using the Volta phase plate with defocus for cryo-EM single particle analysis. eLife, 6, e23006.
- Grant Jensen lectures (https://www.youtube.com/watch?v=mPynoF2j6zc), MRC Cambridge Lectures (<u>https://www2.mrc-lmb.cam.ac.uk/research/scientific-training/electron-microscopy/</u>) all vey useful!

## eBIC Facility



## eBIC Aims

- The UK National Centre for cryo-EM:
  - Free-at-the-point-of-access to state-of-the art facilities.
  - Peer reviewed application process.
  - Beamline-like 24/7 operation supported by expert staff to facilitate intensive external user program.
- Cutting-edge in-house research program under eBIC director Peijun Zhang, Alistair Siebert and Me.....
- Foster the development of integrated structural biology in the UK, linking with other developments, including CCP-EM, EMDB and iNEXT.
- Training courses to bring in structural and cell biologists:
  - 1. MicroED training course (November 2019)
  - 2. Sample preparation training course (November 2019)

## K3 on Krios IV

- K3 has a similar DQE but 3.7x faster than K2 (1500 fps vs 400 fps) and ~50 % larger
- Acquisition dose rates from 14-24 e<sup>-</sup>/px/s
- Typical exposure times 1-3 s
- Automated data collection in SerialEM
- Movies written as LZW compressed Tiffs
- Average movie size 500-600Mb (super-res by default)
- Image shift data collection possible 400 movies per hour





## K3 EPU Integration on Krios III

Data rates- 5 sec stage delay, 3 sec image shift delay, focus every 8µm.

- Lacey: 2µm spacing
  - 135 Mv/Hr
- Quantifoils:
  - 4 shots/hole =140 mv/hr
  - With Fast Acquisition (BETA)
    stage-shift hole clustering
    =200 mv/hour
- Auto functions Now working
- AFIS now available 330 movies per hour



## CryoFIB User Programme Commissioning









## **eBIC** Team

Peijun



















Mart

Josh



Adriana

James

























